1. General description

Planar passivated very sensitive gate Silicon Controlled Rectifier in a SOT54 (TO-92) plastic package.

2. Features and benefits

- Planar passivated for voltage ruggedness and reliability
- Very sensitive gate

3. Applications

- Ignition circuits
- Low power latching circuits
- Protection / shut-down circuits: lighting ballasts
- Protection / shut-down circuits: Switched Mode Power Supplies

4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|--|--|-----|-----|-----|------|
| V_{DRM} | repetitive peak off- state voltage | | - | - | 600 | V |
| V_{RRM} | repetitive peak reverse voltage | | - | - | 600 | V |
| I _{TSM} | non-repetitive peak on- state current | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms | - | - | 9 | Α |
| | | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig. 4; Fig. 5 | - | - | 8 | Α |
| Tj | junction temperature | | - | - | 125 | °C |
| I _{T(AV)} | average on-state current | half sine wave; T _{lead} ≤ 83 °C; <u>Fig. 1</u> | - | - | 0.5 | Α |
| I _{T(RMS)} | RMS on-state current | half sine wave; T _{lead} ≤ 83 °C; <u>Fig. 2;</u> <u>Fig. 3</u> | - | - | 0.8 | Α |
| Static charact | eristics | | | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 10 \text{ mA}; T_j = 25 \text{ °C};$ Fig. 7 | 15 | - | 50 | μΑ |
| Dynamic char | acteristics | | | | | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 125 °C; R_{GK} = 1 k Ω ; (V_{DM} = 67% of V_{DRM}); exponential waveform; Fig. 12 | 100 | - | - | V/µs |

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5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|--------------------|------------------------|
| 1 | Α | anode | | А - [-] - К |
| 2 | G | gate | | Ġ sym037 |
| 3 | K | cathode | TO-92 (SOT54) | Symos |

6. Ordering information

Table 3. Ordering information

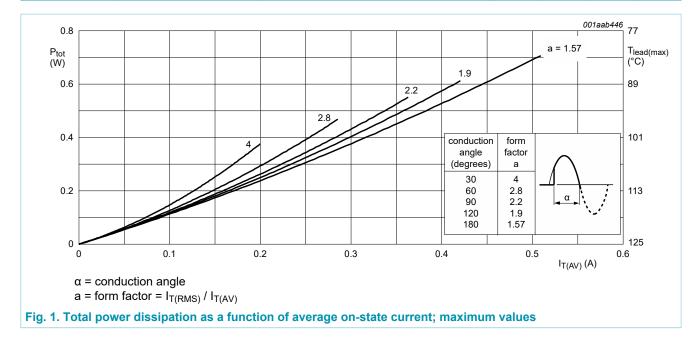
| Type number | Package | | | | |
|-------------|---------|---|---------|--|--|
| | Name | Description | Version | | |
| BT169G-L | TO-92 | plastic single-ended leaded (through hole) package; 3 leads | SOT54 | | |

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7. Limiting values

Table 4. Limiting values
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit |
|---------------------|-----------------------------------|--|-----|------|------|
| V_{DRM} | repetitive peak off-state voltage | | - | 600 | V |
| V_{RRM} | repetitive peak reverse voltage | | - | 600 | V |
| I _{T(AV)} | average on-state current | half sine wave; T _{lead} ≤ 83 °C; <u>Fig. 1</u> | - | 0.5 | Α |
| I _{T(RMS)} | RMS on-state current | half sine wave; T _{lead} ≤ 83 °C; <u>Fig. 2</u> ; <u>Fig. 3</u> | - | 0.8 | Α |
| I _{TSM} | non-repetitive peak on- | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 8.3 ms | - | 9 | Α |
| | state current | half sine wave; $T_{j(init)}$ = 25 °C; t_p = 10 ms; Fig. 4; Fig. 5 | - | 8 | Α |
| l ² t | I ² t for fusing | t _p = 10 ms; SIN | - | 0.32 | A²s |
| dl _T /dt | rate of rise of on-state current | $I_T = 2 \text{ A}$; $I_G = 10 \text{ mA}$; $dI_G/dt = 100 \text{ mA/}\mu\text{s}$ | - | 50 | A/µs |
| I _{GM} | peak gate current | | - | 1 | Α |
| V_{RGM} | peak reverse gate voltage | | - | 5 | V |
| P _{GM} | peak gate power | | - | 2 | W |
| P _{G(AV)} | average gate power | over any 20 ms period | - | 0.1 | W |
| T _{stg} | storage temperature | | -40 | 150 | °C |
| Tj | junction temperature | | - | 125 | °C |



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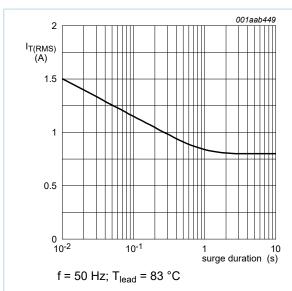


Fig. 2. RMS on-state current as a function of surge duration for sinusoidal currents

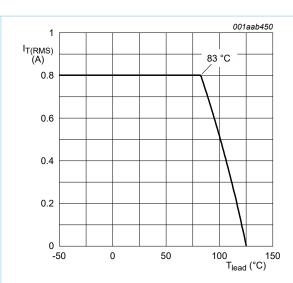


Fig. 3. RMS on-state current as a function of lead temperature; maximum values

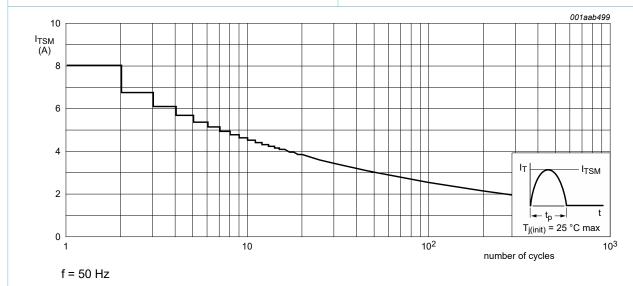
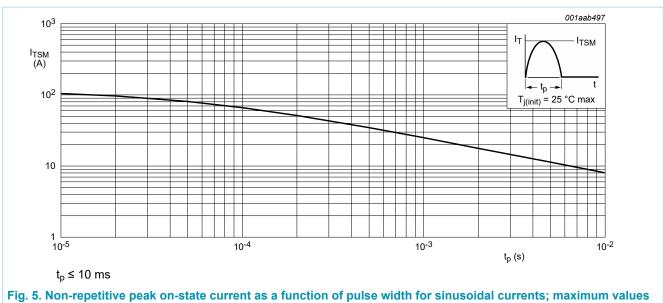


Fig. 4. Non-repetitive peak on-state current as a function of the number of sinusoidal current cycles; maximum values

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8. Thermal characteristics

Table 5. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|-------------------------|--|---|-----|-----|-----|------|
| R _{th(j-lead)} | thermal resistance from junction to lead | <u>Fig. 6</u> | - | - | 60 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient free air | printed circuit board mounted: lead length = 4 mm | - | 150 | - | K/W |

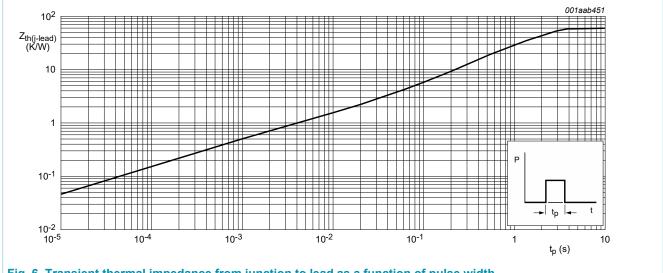


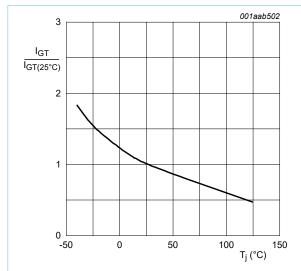
Fig. 6. Transient thermal impedance from junction to lead as a function of pulse width

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9. Characteristics

Table 6. Characteristics

| Symbol | Parameter | Conditions | Min | Тур | Max | Unit |
|---------------------|-----------------------------------|---|-----|------|-----|------|
| Static chara | acteristics | | , | | | |
| I _{GT} | gate trigger current | $V_D = 12 \text{ V}; I_T = 10 \text{ mA}; T_j = 25 ^{\circ}\text{C};$ Fig. 7 | 15 | - | 50 | μΑ |
| lL | latching current | $V_D = 12 \text{ V}; I_G = 0.5 \text{ mA}; T_j = 25 ^{\circ}\text{C};$ Fig. 8 | - | 2 | 4 | mA |
| I _H | holding current | V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u> | - | 0.4 | 1 | mA |
| V_{T} | on-state voltage | I _T = 1.2 A; T _j = 25 °C; <u>Fig. 10</u> | - | 1.25 | 1.7 | V |
| V_{GT} | gate trigger voltage | V _D = 12 V; I _T = 10 mA; T _j = 25 °C; Fig. 11 | - | 0.5 | 0.8 | V |
| | | V _D = 400 V; I _T = 10 mA; T _j = 125 °C; Fig. 11 | 0.2 | 0.3 | - | V |
| I _D | off-state current | $V_D = 600 \text{ V}; R_{GK(ext)} = 1 \text{ k}\Omega; T_j = 25 \text{ °C}$ | - | - | 2 | μΑ |
| | | $V_D = 600 \text{ V}; R_{GK(ext)} = 1 \text{ k}\Omega; T_j = 125 °C$ | - | 0.05 | 0.1 | mA |
| I _R | reverse current | $V_R = 600 \text{ V}; T_j = 25 \text{ °C}; R_{GK(ext)} = 1 \text{ k}\Omega$ | - | - | 2 | μA |
| | | $V_R = 600 \text{ V}; T_j = 125 \text{ °C}; R_{GK(ext)} = 1 \text{ k}\Omega$ | - | 0.05 | 0.1 | mA |
| Dynamic ch | naracteristics | | 1 | ' | ' | |
| dV _D /dt | rate of rise of off-state voltage | V_{DM} = 402 V; T_j = 125 °C; R_{GK} = 1 kΩ; (V_{DM} = 67% of V_{DRM}); exponential waveform; Fig. 12 | 100 | - | - | V/µs |





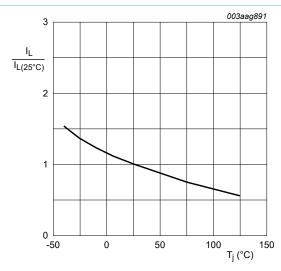


Fig. 8. Normalized latching current as a function of junction temperature

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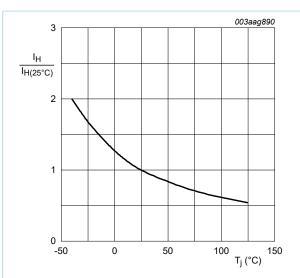
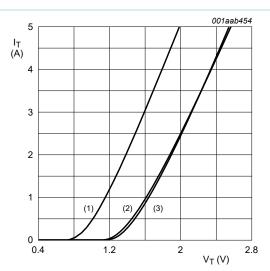


Fig. 9. Normalized holding current as a function of junction temperature



 V_o = 1.067 V; R_s = 0.187 Ω

(1) T_j = 125 °C; typical values (2) T_j = 125 °C; maximum values

(3) T_i = 25 °C; maximum values

Fig. 10. On-state current as a function of on-state voltage

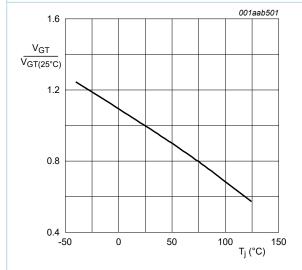


Fig. 11. Normalized gate trigger voltage as a function of junction temperature

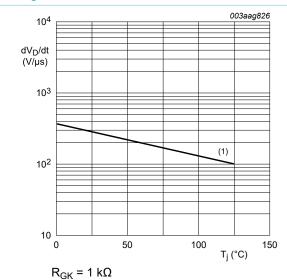
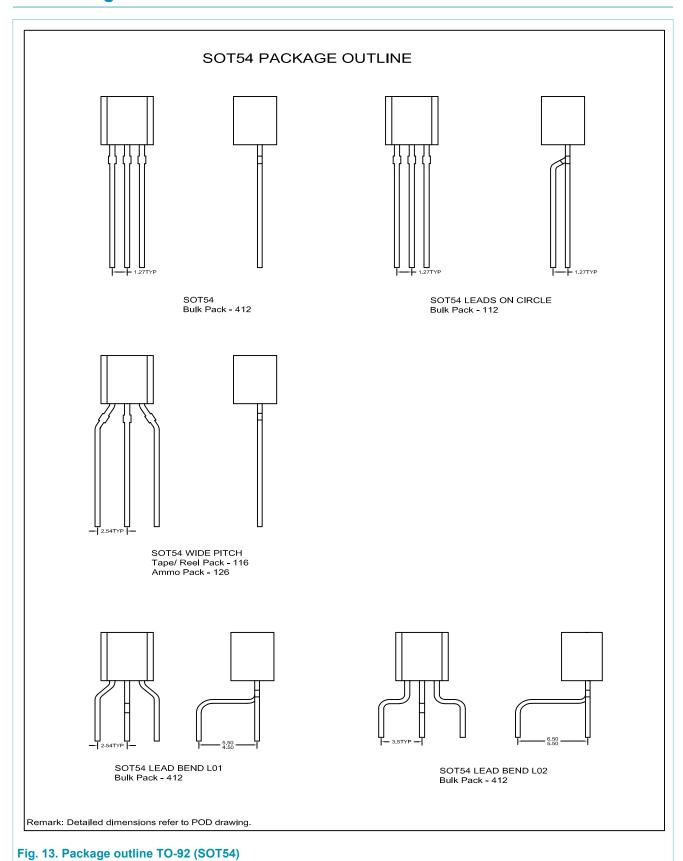


Fig. 12. Critical rate of rise of off-state voltage as a function of junction temperature; typical values

10. Package outline



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11. Legal information

Data sheet status

| Document status [1][2] | Product status [3] | Definition |
|--------------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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